

**Notice of References Cited**

Application/Control No.

10/797,664

Applicant(s)/Patent Under  
Reexamination  
VAN GROOS ET AL.

Examiner

Peter B. Kim

Art Unit

2851

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*	B	US-2003/0045131 A1	03-2003	Verbeke et al.	438/795
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	M	US-			

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